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# PERIODIC TIME-VARYING NOISE IN CURRENT-COMMUTATING CMOS MIXERS

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**Abstract**—An analytical approach based on linear periodic time-varying theory, is developed to analyze the noise characteristics of current-commutating CMOS mixers. Based on the derived transfer functions with memory effect of tail capacitance, the frequency-dependent noise transforming factors for individual stages in the mixers are numerically computed to rigorously describe the noise output. A unified noise expression considering both the thermal noise and the flicker noise is proposed. It enables the noise analysis of the mixers particularly for a high LO frequency with different IF characteristics, and is verified by measurements.

## 1. INTRODUCTION

Direct conversion receivers (DCR) with the advantage of low cost and high integration, have gained more increased commercial market quotient among various receiver architectures [9]. For DCR, not only thermal noise from mixers, but also flicker noise can seriously deteriorate the overall system performance. On the other hand, the active mixer in which switching pairs are used for current commutating is more attractive in many applications because it provides higher conversion gain, resulting in improved suppression of noise contribution from subsequent stages [1, 10]. Therefore it is undoubtedly significant to accurately analyze and predict the noise characteristics of current-commutating mixers [2].

Different from the time invariant noise in low noise amplifiers [3], the time varying characteristic of noise in mixers complicates its analysis process much [11]. Until now, efforts to understand noise in mixers on a more intuitive basis only have resulted in a few

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representative analytical methods [4, 5]. The physical analytical model proposed in [5] roughly approximates that switching pairs commutate instantly, and resulting periodic noise pulses are randomly modulated by the ideal rectangular output current, which is only appropriate for a large sinusoidal LO swing. As the memory elements such as capacitors are commonly ignored, these approaches are only valid for low frequency, which thus makes the practical design of mixers with high LO frequency greatly dependent on the CAD tools such as Cadence, ADS and etc. In this work, an analytical approach based on linear periodic time-varying (LPTV) theory, is developed to analyze the noise characteristics of the mixer, incorporating memory effect of tail capacitance. The proposed analysis approach is a generalization for [4], and ultimately validated by measurements.

The paper is organized as follows. In Section 2, the noise analysis for the mixer is presented through deriving corresponding periodic transfer functions. And in Section 3, measurements verify the theory. Finally, conclusions are drawn in Section 4.

## 2. NOISE ANALYSIS

Without losing generality, the current-commutating CMOS mixer shown in Fig. 1 is examined. It is composed of an input transconductance stage ($M_3$), switching pairs ($M_1$ and $M_2$), and output loads ($R_L$). In principle, $M_1$ and $M_2$ commutate the tail current $I_3$ under the control of LO signal $V_{LO}(t)$ and complete the frequency transformation from the RF to the IF, while $M_3$ converts the RF voltage signal $v_{RF}$ to the current $i_{RF}$. In GHz frequency range, parasitic effects can not be neglected. Tail capacitance observed towards $x$ is generally far more than other nets and becomes a main bottleneck limiting noise performance in high frequency [4]. On the other hand, this capacitance consists of the gate-source capacitance of $M_1$ and $M_2$ (i.e., $C_{gs1}$ and $C_{gs2}$) and the junction capacitances at the source of $M_1$ and $M_2$ and the drain of $M_3$. Since they appear as a nonlinear function of the applied voltage, these junction capacitances make the following analysis using the linear periodic time-varying theory exceedingly complicated. To overcome this difficulty, we approximate these junction capacitances as a time-invariant capacitance $C_{eff}$. As a result, the total capacitance at the tail node is the sum of $C_{gs1}$, $C_{gs2}$ and $C_{eff}$ just as in [5], and is defined as a time-invariant $C_p$ illustrated by the dash line in Fig. 1.

The noise is contributed by all the devices in theory. Based on the derived transfer functions with the tail capacitance $C_p$, the frequency-dependent noise characteristic in the mixer, is systematically analyzed

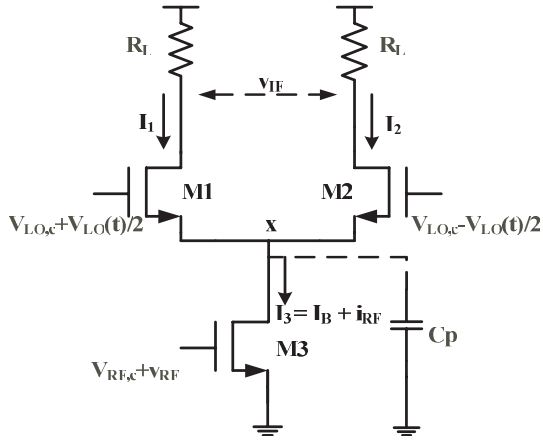


**Figure 1.** Current-commutating CMOS mixer.

using LPTV theory throughout this section. For clarity of discussion, the review of the fundamental LPTV theory is also summarized in the appendix [6].

### 2.1. Noise from the Transconductance Stage

By small signal analysis, the fundamental transfer function from the RF port to the IF port, takes the form

$$P(t,\omega) = \frac{g_{m1} - g_{m2}}{g_{m1} + g_{m2} + j\omega C_p} \tag{1}$$

where parameter $g_{m1,2}$ is transconductance of $M_{1,2}$, and can be iteratively solved by switching pairs' equation in [4]. $P(t,\omega)$ is periodic since $g_{m1,2}$ is time-varying in one LO period, $T_{LO}$. According to the appendix, we thus can derive $n$th order frequency-dependent Fourier coefficient of $P(t,\omega)$ as below

$$P_n(\omega) = \frac{1}{T_{LO}} \int_0^{T_{LO}} P(t, \omega - n\omega_{LO}) \exp(-jn\omega_{LO}t)\, dt \tag{2}$$

where $\omega_{LO}$ donates the LO angular frequency.

As a result, the conversion gain (CG) of the current-commutating mixer is

$$CG = c(\omega) \cdot g_{m3} R_L \tag{3}$$

where parameters $c(\omega)$ and $g_{m3}$ are the switching pairs gain coefficient and transconductance for $M_3$. According to (A5), for the down

conversion action with RF frequency $f_{RF}$ being higher than LO frequency $f_{LO}$ we can have

$$c(\omega_{IF}) = |P_{-1}(\omega_{IF})| = \left| \frac{1}{T_{LO}} \int_0^{T_{LO}} \frac{g_{m1} - g_{m2}}{g_{m1} + g_{m2} + j\omega_{RF} C_p} \exp(j\omega_{LO} t)\, dt \right| \tag{4}$$

where $\omega_{RF}$ and $\omega_{IF}$ are the RF and IF angular frequency, and $\omega_{RF}$ corresponds to $\omega_{LO} + \omega_{IF}$. When $f_{LO}$ is high enough (here we take IF frequency $f_{IF}$ near to zero for convenience of expressing and exemplifying in Fig. 2. As for higher $f_{IF}$, things are similar only with further decreased amplitude), RF signal will be inevitably attenuated by the parasitic $C_p$. In other words, as shown in Fig. 2, the transfer function $p(t, \omega)$ is lowered, and the waveform amplitude of that is even less than one. So $c(\omega)$ is decreased correspondingly. Fig. 3 displays the relation of $c(\omega)$ vs. the bias current $I_B$ with different $f_{LO}$.

In transconductance stage, the noise sources include the thermal channel noise current of $M_3$, the input source resistance $R_s$ and the polysilicon gate resistance $r_{g3}$. According to the LPTV theory, the noise power spectral density (PSD) transformed to the output due to the wide-sense-stationary (WSS) noise input at the transconductance stage is

$$S_{n3}^{o}(\omega) = \sum_{n=-\infty}^{\infty} |P_n(\omega)|^2 \cdot 4kT \left( R_s + r_{g3} + \frac{\gamma}{g_{m3}} \right) g_{m3}^2 \tag{5}$$

where $\gamma$ is the noise coefficient of devices. And we also define the noise transforming factor of transconductance stage $\alpha(\omega) = \sum_{n=-\infty}^{\infty} |P_n(\omega)|^2$.

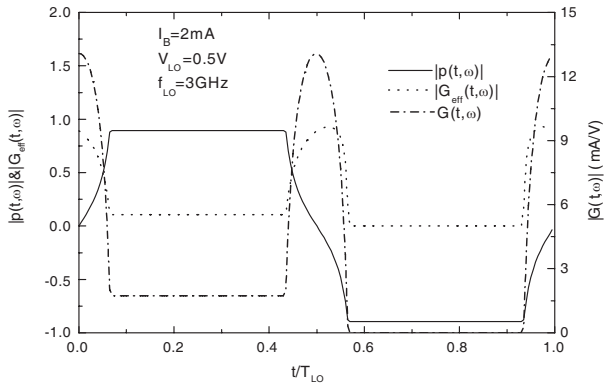


**Figure 2.** $|P(t, \omega)|$, $|G_{eff}(t, \omega)|$, and $|G(t, \omega)|$ in $T_{LO}$ when $I_B = 2\,\mathrm{mA}$, $V_{LO} = 0.5\,\mathrm{V}$, $f_{LO} = 3\,\mathrm{GHz}$.

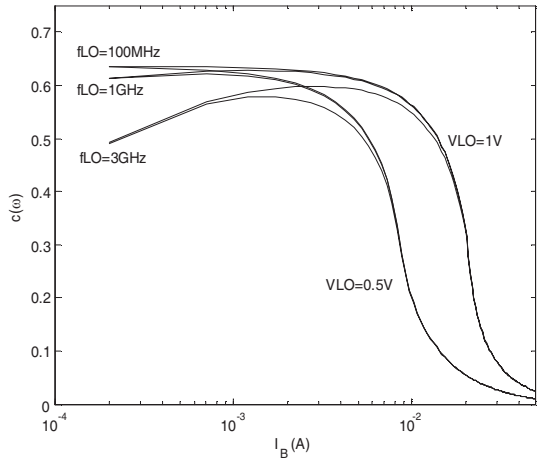


**Figure 3.** Numerically computed gain coefficient $c(\omega)$.

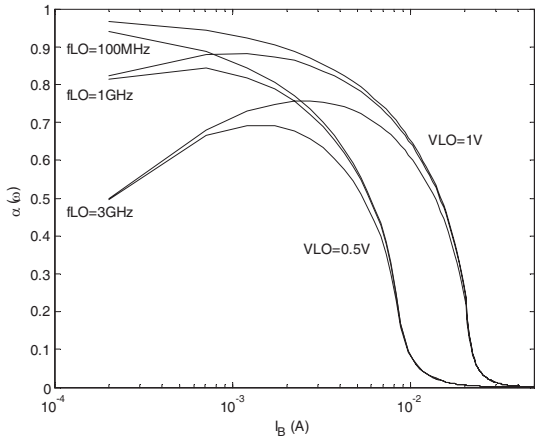


**Figure 4.** Numerically computed transforming factor $\alpha(\omega)$.

As shown in Fig. 4, high $f_{LO}$ will decrease the numerical value of $\alpha(\omega)$, which is similar to $c(\omega)$.

## 2.2. Noise from the LO Port Resistance

Similarly, the periodic transfer function from the LO port at the gate of $M_1$ and $M_2$ side, respectively to the differential IF port, $G(t, \omega)$ and

$H(t,\omega)$ take the form as below

$$G(t,\omega) = \frac{g_{m1}(2g_{m2} + j\omega C_p)}{g_{m1} + g_{m2} + j\omega C_p} \quad H(t,\omega) = \frac{g_{m2}(2g_{m1} + j\omega C_p)}{g_{m1} + g_{m2} + j\omega C_p}. \quad (6)$$

Due to the periodicity of switching pairs functioning one can see $g_{m1}(t) = g_{m2}(t - T_{LO}/2)$ and $g_{m2}(t) = g_{m1}(t - T_{LO}/2)$. Meanwhile, according to LPTV theory, we can have the below relationship of $n$th order frequency-dependent Fourier coefficient $G_n(\omega)$ and $H_n(\omega)$

$$\begin{aligned} G_n(\omega) =& \frac{1}{T_{LO}} \int_0^{T_{LO}} G(t, \omega - n\omega_{LO}) \exp(-jn\omega_{LO}t)\, dt \\ H_n(\omega) =& \frac{1}{T_{LO}} \int_0^{T_{LO}} H(t, \omega - n\omega_{LO}) \exp(-jn\omega_{LO}t)\, dt \\ =& \frac{1}{T_{LO}} \int_0^{T_{LO}} G(t - T_{LO}/2, \omega - n\omega_{LO}) \exp(-jn\omega_{LO}t)\, dt \\ =& G_n(\omega)/(-1)^n \end{aligned} \quad (7)$$

Considering the symmetry of switching pairs, the noise contribution to the output at LO port thus is simplified as

$$\begin{aligned} S^o_{nLO}(\omega) &= \sum_{n=-\infty}^{\infty} |G_n(\omega)|^2 4kT(R_{LO}/2 + r_{g1}) \\ &\quad + \sum_{n=-\infty}^{\infty} |H_n(\omega)|^2 4kT(R_{LO}/2 + r_{g2}) \\ &= \sum_{n=-\infty}^{\infty} |G_n(\omega)|^2 4kT(R_{LO} + 2r_{g1}) \end{aligned} \quad (8)$$

where $R_{LO}$, $r_{g1,2}$ are the equivalent noise resistance of LO port, and the polysilicon gate resistance of $M_{1,2}$. And we also define the noise transforming factor of switching pairs $\beta(\omega) = \sum_{n=-\infty}^{\infty} |G_n(\omega)|^2$.

The periodic waveform in $T_{LO}$ for the transfer function $|G(t,\omega)|$ is also exemplified in Fig. 2 with the typical $I_B = 2\,\text{mA}$, $V_{LO} = 0.5\,\text{V}$, and $f_{LO} = 3\,\text{GHz}$. Fig. 5 depicts the relation of $\beta(\omega)$ vs. $I_B$ with different $f_{LO}$.

### 2.3. Noise from Switching Transistors

Since the channel noise of switching transistors is cyclostationary instead of WSS, the related analysis gets troublesome. Fortunately, the cyclostationary noise source can be modeled as modulated stationary

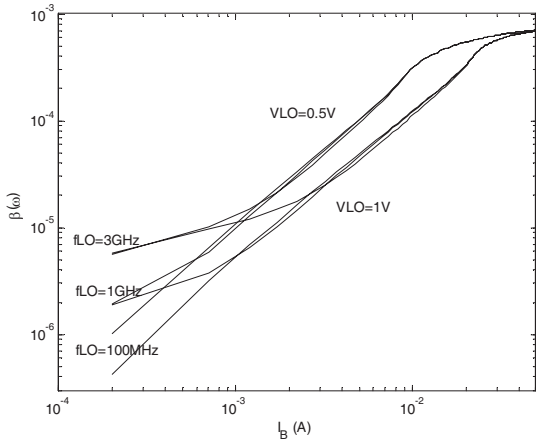


**Figure 5.** Numerically computed transforming factor of LO port at $M_1$ side $\beta(\omega)$.

noise sources. And the modulated effect can be incorporated in the periodic transfer function. Take $M_1$ for example, its cyclostationary noise $4\,\mathrm{kT}\gamma g_{m1}$ is modeled as a WSS noise $4\,\mathrm{kT}\gamma g_{m1\,\max}$ modulated by a periodic waveform with normalized amplitude $g_{m1}/g_{m1\,\max}$ ($g_{m1\,\max}$ being the maximum of $g_{m1}$ in $T_{LO}$). The corresponding effective periodic transfer function with modulated effect, thus takes the form

$$G_{\mathit{eff}}\left(t,\omega\right) = \sqrt{\frac{g_{m1}}{g_{m1,\max}}}\frac{2g_{m2}+j\omega C_p}{g_{m1}+g_{m2}+j\omega C_p}. \tag{9}$$

And we also define the effective noise transforming factor of switching pairs $\beta_{\mathit{eff}}\left(\omega\right) = \sum_{n=-\infty}^{\infty}\left|G_{\mathit{eff},n}\left(\omega\right)\right|^2$. Then we also have

$$G_{\mathit{eff},n}\left(\omega\right) = \frac{1}{T_{LO}}\int_0^{T_{LO}} G_{\mathit{eff}}\left(t,\omega-n\omega_{LO}\right)\exp\left(-jn\omega_{LO}t\right)dt. \tag{10}$$

As a result, the noise PSD contribution to the output due to $M_1$ is

$$S^o_{n1,wte}\left(\omega\right) = \sum_{n=-\infty}^{\infty}\left|G_{\mathit{eff},n}\left(\omega\right)\right|^2 4KT\gamma\cdot g_{m1,\max}. \tag{11}$$

The periodic waveform of transfer function $|G_{\mathit{eff}}(t,\omega)|$ in $T_{LO}$ is also quantitatively depicted in Fig. 2 with the same $I_B = 2\,\mathrm{mA}$, $V_{LO} = 0.5\,\mathrm{V}$, and $f_{LO} = 3\,\mathrm{GHz}$. As shown in Fig. 6, high $f_{LO}$ will roughly increase the numerical value of effective noise transforming factor of switching pairs $\beta_{\mathit{eff}}(\omega)$, which is similar to $\beta(\omega)$.

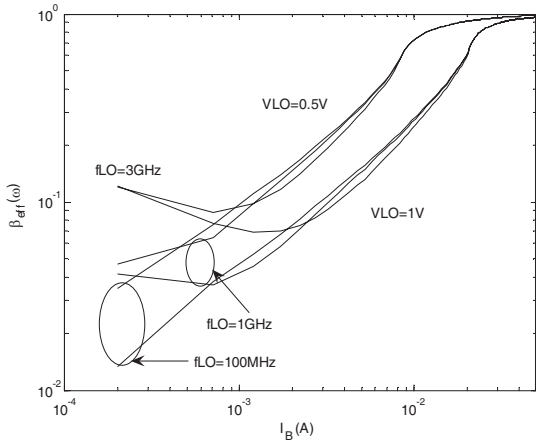


**Figure 6.** Numerically computed effective transforming factor $\beta_{eff}(\omega)$.

### 2.4. Flicker Noise

The flicker noise of the mixer exclusively arises from the leakage from switching pairs $M_{1,2}$ [4, 5]. Considering the characteristic of flicker noise, its output PSD due to $M_1$ can be simplified from (8) as follows

$$S^o_{n1,flk}(\omega) = |G_0(\omega)|^2 \overline{V^2_{n1}}. \tag{12}$$

where parameter $G_0(\omega)$ is the time-average of transfer function $G(t, \omega)$ in $T_{LO}$, and can be obtained according to (7). Moreover, the flicker noise of $M_1$ is [5]

$$\overline{V^2_{n1}} = \frac{K_f}{C_{OX} W_1 L} \frac{1}{f} \tag{13}$$

where parameter $K_f$ is a process parameter. This model is not as accurate as the BSIM3v3 model, but serves as analytical formulation and has been extensively used to model flicker noise for the first-order approximate solutions.

### 2.5. Noise Figure

Based on the noise contributions in above, with the symmetry of switching pairs, the single sideband (SSB) noise figure (NF) for the current-commutating mixer is

$$NF = \frac{S^o_{n3}(\omega) + 2S^o_{n1,wte}(\omega) + 2S^o_{n1,flk}(\omega) + S^o_{nLO}(\omega) + S^o_{nRL}}{c(\omega)^2 g^2_{m3} 4kTR_s} \tag{14}$$

where the noise from the loads $R_L$, $S_{nRL}$ is

$$S^o_{nRL} = 8kT/R_L. \tag{15}$$

On the whole, this noise expression is unified in that it consists of not only the thermal noise but also the flicker noise, which thus make it suitable for the current-commutating mixer with different IF characteristics. If $f_{IF}$ is high enough to make the flicker noise close to zero and $C_p$ is neglected, (14) reduces to the conventional prediction expression for low frequency in [4]. As shown in the next section, only by numerically computing several frequency-dependent noise transforming factors, the noise characteristic of the mixer can be conveniently predicted even if $f_{LO}$ is high, which is fairly desirable for designs and optimizations.

## 3. RESULTS AND DISCUSSIONS

To validate the analysis experimentally, the SSB noise figures of a current-commutating mixer fabricated in Chartered 0.18 µm CMOS technology were measured at low and high point frequencies, respectively. Low and high point frequencies of 100 kHz and 100 MHz were obtained by tuning the frequency of RF input signal while the LO frequencies were fixed at 1 GHz and 3 GHz, respectively. The measurement setup and micrograph of die are shown in Fig. 7, where an off-chip balun was used to generate the differential LO signal for

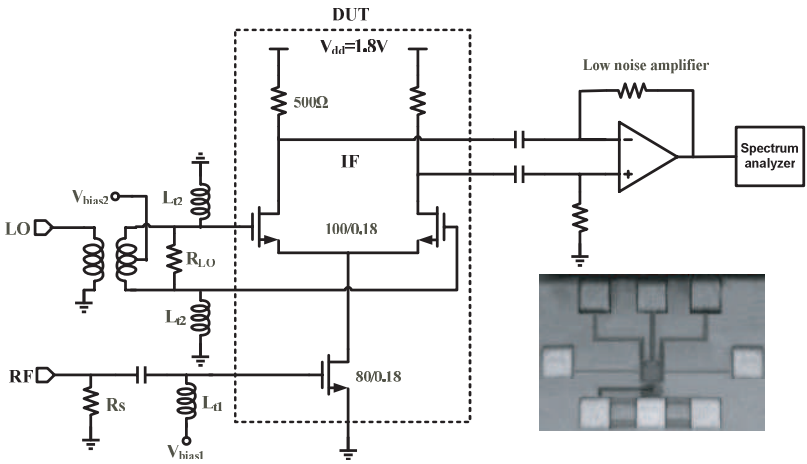


**Figure 7.** Measurement setup of current-commutating CMOS mixer and die micrograph.

**Table 1.** Summary of extracted parameters for simulations.

| | | | |
|---|---|---|---|
| $K_1$ | 77.8 mA/V$^2$ | $r_{g3}$ | 8.26 Ω |
| $\theta$ | 2.76 | $r_{g1,2}$ | 10.33 Ω |
| $R_s$ | 50 Ω | $C_p$ | 310 fF |
| $R_{LO}$ | 50 Ω | $K_f$ | 8.5E-24V$^2$F |

switched pairs. Off-chip inductors $L_{t1}$, $L_{t2}$ were tuned at RF and LO frequency to absorb the net parasitic capacitances at RF port and LO port, and provided the corresponding impendence matching. $V_{bias1}$ and $V_{bias2}$ are DC biases of RF port and LO port, respectively. To measure the output noise, a low noise amplifier (using LT1007) was adopted to convert differential current noise into single-ended one and feed it to the spectrum analyzer. The noise contribution from this active balun acted as the test load, has been deducted from the test data. The extracted parameters for numerical simulations are shown in Table 1 where parameters $K_1$ and $\theta$ obey the definition in [4]. Especially, the noise coefficient for short channel devices $\gamma$ approximately takes 2.5 [7].

The expression (14) is a unified expression for estimating the noise of the mixer with different IF characteristics. According to the IF being high or low, the analysis is discussed as follows, respectively.

In superheterodyne receiver with high IF, flicker noise is negligible. Take $f_{IF} = 100$ MHz for example, the noise and gain characteristic is compared between predictions and measurements. As shown in Fig. 8, the optimum NF appears at lower current than the optimum CG does. Take $V_{LO} = 0.5$ V, $f_{LO} = 1$ GHz for example, the simulated optimum NF is 11.7 dB at $I_B = 1.5$ mA while the simulated optimum CG is 13.2 dB at $I_B = 3.8$ mA. In view of power consumption, it is desirable that $I_B$ takes 1.5 mA, since the signal noise ratio is little changed in this current range. Similarly it is also true to the analysis for $V_{LO} = 0.5$ V, $f_{LO} = 3$ GHz although the corresponding optimum NF and CG is increased by 0.5 dB and $-0.3$ dB or so, respectively. The reason for this is attributed to the deteriorated transforming factors $c(\omega)$, $\alpha(\omega)$, $\beta(\omega)$, and $\beta_{eff}(\omega)$ resulted by increased $f_{LO}$ as in Figs. 3–6.

For the DCR with low IF, flicker noise will get prominent. Fig. 9 presents the measured mixer output current noise PSD with $f_{LO} = 3$ GHz, where the bias $I_B$ is fixed at 1 mA and $V_{LO}$ takes 0.5 and 1 V, respectively. The frequency (i.e., $f_{IF}$) is scanned between 10 kHz and 500 kHz. As in the figure, the spectrum of measured noise clearly exhibits a $1/f$ frequency dependency. And higher $V_{LO}$ notably reduces the flicker noise output, which is consistent with the results observed in [4].

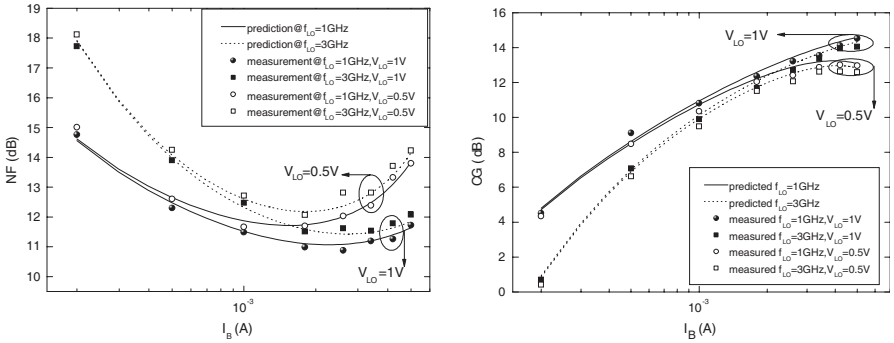


**Figure 8.** Predicted and measured NF and CG vs. $I_B$ at $f_{IF} = 100\,\text{MHz}$.

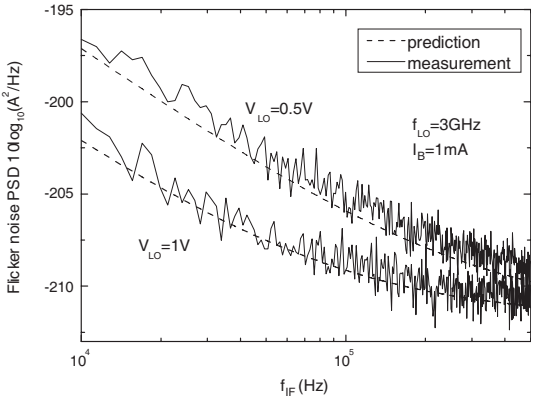


**Figure 9.** Predicted and measured flicker noise PSD of the mixer.

Then take the fixed $f_{IF} = 100\,\text{kHz}$ for example, the noise characteristic is examined with the typical $V_{LO} = 0.5, 1\,\text{V}$ and $f_{LO} = 1, 3\,\text{GHz}$, respectively. As shown in Fig. 10, it is noted that the optimum NF appears at lower current than that for high IF case in Fig. 8. Take $V_{LO} = 1\,\text{V}$ for example, the simulated optimum NF is about 1339 dB at $I_B = 0.6\,\text{mA}$ for $f_{LO} = 1\,\text{GHz}$ while it takes 1518 dB or so at $I_B = 1\,\text{mA}$ for $f_{LO} = 3\,\text{GHz}$. The reason for this phenomenon lies in that the NF for low IF is clearly increased due to the flicker noise from switching pairs.

According to (4), the conversion gain for low $f_{IF}$ in principle should be higher than that for high $f_{IF}$ because for low $f_{IF}$, a lower RF signal in equivalence is applied to the gate of M3 under the fixed $f_{LO}$. However, $f_{LO}$ is normally far higher than $f_{IF}$ (no matter low and high $f_{IF}$), which makes CG differences due to the different $f_{IF}$ quite subtle,

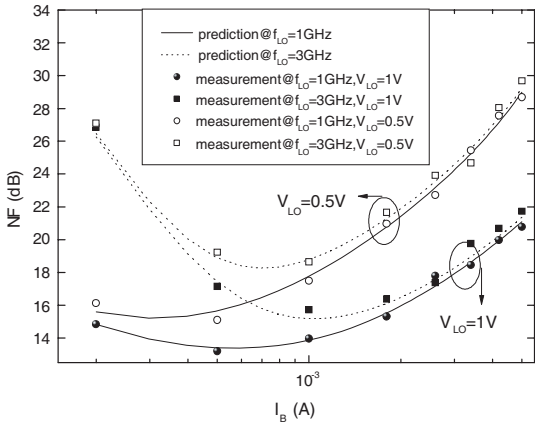


**Figure 10.** Predicted and measured NF vs. $I_B$ at $f_{IF} = 100\,\text{kHz}$.

and normally comparable to measurement errors On the other hand, if $f_{IF}$ is fixed, a high $f_{LO}$ leads to a clearly low conversion gain since the absolute variation of $f_{LO}$ is much larger than the $f_{IF}$ itself. Here, take $V_{LO} = 1\,\text{V}$ for example, with the fixed $f_{IF} = 100\,\text{MHz}$ and $I_B = 1\,\text{mA}$, the simulated CG shown in Fig. 8 is 10.97 dB for $f_{LO} = 1\,\text{GHz}$, but decreases to 10.14 dB for $f_{LO} = 3\,\text{GHz}$. The CG results for low $f_{IF}$ case are little different from high $f_{IF}$ case in Fig. 8, and therefore are omitted.

From above analysis, (14) and (3) can assist designers to obtain the improved noise and conversion gain performances by capturing the optimized bias current under different LO levels. As the parasitic tail capacitance is considered, the two predicted expressions make them effectively applicable to high $f_{LO}$ situations On the whole, for both IF characteristics, the measured NF and CG well agree with the predictions even when $f_{LO}$ becomes as high as 3 GHz. Additionally, Cadence simulations also justify our theory's validity below 5 GHz The proposed approach based on LPTV theory also is of possibility to predict noise at even higher frequency provided that more net capacitances in the mixer are included in the transfer functions, although which often makes the related derivations too complex in effect to gain intuitive insights (For example, gain drain capacitances $C_{gd}$ of $M_{1,2}$ are not included in our analysis in the interest of simplicity). The NF discrepancy between predictions and measurements is mainly attributed to the fact that parameter $\gamma$ is not solely dependent on channel length of devices, but related to bias current, drain and body voltage of devices. For example, a recent research finds that low current density generally yields a small $\gamma$ [8].

## 4. CONCLUSIONS

An analytical approach based on linear periodic time-varying theory is developed to analyze the noise characteristics of current-commutating CMOS mixers. Based on the derived transfer functions with memory effect of tail capacitance, the frequency-dependent noise transforming factors for individual stages in the mixers are numerically computed to rigorously describe the noise output. A unified noise figure expression including both the thermal noise and the flicker noise has been proposed. It displays advantages particularly when LO frequency is high, and therefore can serve as a guideline for predicting and optimizing noise of the mixers in different receiver architectures.

## ACKNOWLEDGMENT

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## APPENDIX A.

The relation between the input $x(t)$ and the output $y(t)$ for a linear time-varying system, can be given by

$$y(t) = \int_{-\infty}^{\infty} h(t,u)\, x(u)\, du = \frac{1}{2\pi} \int_{-\infty}^{\infty} H(t,\omega)\, X(\omega)\, e^{j\omega t} dt \qquad \text{(A1)}$$

where $h(t,u)$ is the impulse response with $u$ denoting the launch time and $t$ denoting the observation time, and $H(t,\omega)$ is the time-varying transfer function with $\omega$ donating the angular frequency corresponding to the delay $\nu$ $(= t-u)$. Moreover, $h(t,u)$ and $H(t,\omega)$ are a pair of Fourier transform with respect to $\nu$,

$$\begin{aligned} h(t,u) &= \frac{1}{2\pi} \int_{-\infty}^{\infty} H(t,\omega)\, e^{j\omega v} d\omega \\ H(t,\omega) &= \int_{-\infty}^{\infty} h(t,u)\, e^{-j\omega v} dv. \end{aligned} \qquad \text{(A2)}$$

Mixers driven by the periodic LO signal are commonly modeled as LPTV systems [2, 7]. As a result, $h(t,u)$ and $H(t,\omega)$ for mixers become periodic with respect to $T_{LO}$, and can be represented by Fourier series (assumed to converge), i.e., [6]

$$h(t,u) \quad = \sum_{n=-\infty}^{\infty} h_n(v)\, e^{jn\omega_{LO}u}$$

$$H(t,\omega) = \sum_{n=-\infty}^{\infty} H_n(\omega + n\omega_{LO}) e^{jn\omega_{LO}t} \tag{A3}$$

where $h_n(\nu)$ and $H_n(\omega)$ are $n$th order harmonic impulse response and $n$th order harmonic transfer function, respectively. We also can rewrite the bottom of (A3) in the form below

$$H_n(\omega) = \frac{1}{T_{LO}} \int_0^{T_{LO}} H(t, \omega - n\omega_{LO}) \exp(-jn\omega_{LO}t)\, dt. \tag{A4}$$

Substituting the top of (A3) into (A1) and taking Fourier transform to the resulting $y(t)$, we obtain

$$Y(\omega) = \sum_{n=-\infty}^{\infty} H_n(\omega) X(\omega - n\omega_{LO}) \tag{A5}$$

where $X(\omega)$ is the Fourier transform of deterministic input $x(t)$. Equations (A4) and (A5) well describe the frequency translation of mixers. Take down conversion for example, variables $X$, $Y$ just correspond to RF input and IF output signal, respectively. Meanwhile, 1st harmonic coefficient is usually adopted for high conversion efficiency in mixers. Thus (A5) reduces to $Y(\omega_{IF}) = H_{-1}(\omega_{IF})X(\omega_{IF} + \omega_{LO})$ with n taking $-1$, representing $f_{RF}$ located at the right sideband of $f_{LO}$. And the left sideband scenario can be described by taking $n = 1$. According to (A4), we can capture $H_{-1}(\omega_{IF})$ from $H(t, \omega_{IF} + \omega_{LO})$ derived from RF input to IF output in small signal circuit analysis. The conversion gain thus can be computed.

On the other hand, for a WSS noise input $x(t)$, the output $y(t)$ can be shown to be a cyclostationary process. Similarly, the autocorrelation function $R_y(t,\tau)$ and the output PSD $S_y(t,\omega)$ are also periodic with respect to $T_{LO}$, thus can be represented by Fourier series (assumed to converge), i.e., [6]

$$\begin{aligned} R_y(t,\tau) &= \sum_k R_y^k(\tau) e^{jk\omega_{LO}t} \\ S_y(t,\omega) &= \sum_k S_y^k(\omega) e^{jk\omega_{LO}t}. \end{aligned} \tag{A6}$$

And we have the definition of the output autocorrelation harmonic function [6]

$$R_y^k(\tau) = \lim_{T_{LO}\to\infty} \frac{1}{T_{LO}} \int_{-T_{LO}/2}^{T_{LO}/2} R_y\left(t + \frac{\tau}{2}, t - \frac{\tau}{2}\right) e^{-jk\omega_{LO}t} dt \tag{A7}$$

where $\tau$ is the correlation time. Furthermore, the output autocorrelation harmonic function $R_y^k(\tau)$ and the output PSD

harmonic function $S_y^k(\omega)$ constitute another pair of Fourier transform. As a result, the output autocorrelation harmonic function of mixers is obtained by substituting (A1) and (A3) into (A7)

$$R_y^k(\tau) = \sum_{n=-\infty}^{\infty} \left[ \langle R_x(\tau) \rangle e^{-j\frac{\pi}{T_{LO}}(2n-k)\tau} \right] \otimes r_{n,(n-k)}^k(-\tau) \tag{A8}$$

where

$$r_{n,(n-k)}^k(\tau) = \int_{-\infty}^{\infty} h_n\left(t+\frac{\tau}{2}\right) h_{n-k}^*\left(t-\frac{\tau}{2}\right) e^{-jk\omega_{LO}t} dt.$$

Here, symbols "$\otimes$" and "$*$" indicate convolution and conjugate operation, respectively. Moreover, the definition of autocorrelation function for WSS noise input $x(t)$ is [6]

$$\langle R_x(\tau) \rangle = \lim_{T_{LO}\to\infty} \frac{1}{T_{LO}} \int_{-T_{LO}/2}^{T_{LO}/2} R_x\left(t+\frac{\tau}{2}, t-\frac{\tau}{2}\right) dt. \tag{A9}$$

Taking Fourier transform to (A8) yields

$$\begin{aligned} S_y^k(\omega) = & \sum_{m=-\infty}^{\infty} H_{m+k}\left(\omega + \frac{k\omega_{LO}}{2}\right) \left\langle S_x\left(\omega - \left(\frac{k}{2}+m\right)\omega_{LO}\right)\right\rangle \\ & H_m^*\left(\omega - \frac{k\omega_{LO}}{2}\right). \end{aligned} \tag{A10}$$

According to LPTV theory, the PSD of the cyclostationary process at any two frequencies that are separated by multiples of the LO frequency are correlated. The correlations in different components of $S_y^k(\omega)$ may constitute potential problems in mixers. Fortunately, after limited bandwidth filtering with central frequency $\omega$, the components of $S_y^k(\omega)$ for $k \neq 0$ are eliminated. As a result, the output of mixers becomes stationary and the resulting output spectrum simply is the time average of $S_y(t,\omega)$ in $T_{LO}$ as shown below

$$S_y^0(\omega) = \overline{S_y(t,\omega)} = \sum_{n=-\infty}^{\infty} |H_n(\omega)|^2 S_x(\omega - n\omega_{LO}). \tag{A11}$$

If mixers are memoryless, we have $h(t,u) = h(t)\delta(t-u)$ and therefore $y(t) = h(t)x(t)$. Substituting it into (A2) and (A3), we have $H(t,\omega) = h(t)$ and $H_n(\omega) = H_n$. Its PSD thus reduces to $S_y(\omega) = \sum\limits_{n=-\infty}^{\infty} |H_n|^2 S_x(\omega - n\omega_{LO})$, which is simply assumed in the conventional analysis for mixers.

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